



US00D724214S

(12) **United States Design Patent**
Ihara

(10) **Patent No.:** **US D724,214 S**
(45) **Date of Patent:** **** Mar. 10, 2015**

(54) **ANALYZING MACHINE HAVING X-RAY**

(56)

References Cited

U.S. PATENT DOCUMENTS

D424,199	S	*	5/2000	Wells	D24/158
D441,080	S	*	4/2001	Herekar et al.	D24/158
D489,816	S	*	5/2004	Ross	D24/186
D508,565	S	*	8/2005	Nepkin et al.	D24/186
D647,209	S	*	10/2011	Muller et al.	D24/216
D689,193	S	*	9/2013	Shinohara et al.	D24/216
D702,350	S	*	4/2014	Nasella	D24/158
2013/0272498	A1	*	10/2013	Goto et al.	378/45

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(**) Term: **14 Years**

* cited by examiner

(21) Appl. No.: **29/471,850**

Primary Examiner — Anhdao Doan

(22) Filed: **Nov. 6, 2013**

(74) *Attorney, Agent, or Firm* — Jianq Chyun IP Office

(30) **Foreign Application Priority Data**

(57) **CLAIM**

The ornamental design for an analyzing machine having X-ray, as shown and described.

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DESCRIPTION

(51) **LOC (10) Cl.** **24-01**

FIG. 1 is a perspective view of an analyzing machine having X-ray showing my new design;

(52) **U.S. Cl.**

FIG. 2 is another perspective view thereof;

USPC **D24/158; D24/216**

FIG. 3 is a front view thereof;

(58) **Field of Classification Search**

USPC D24/158-161, 185, 186, 216;
378/44-47, 64, 66, 88

FIG. 4 is a rear view thereof;

FIG. 5 is a left side view thereof;

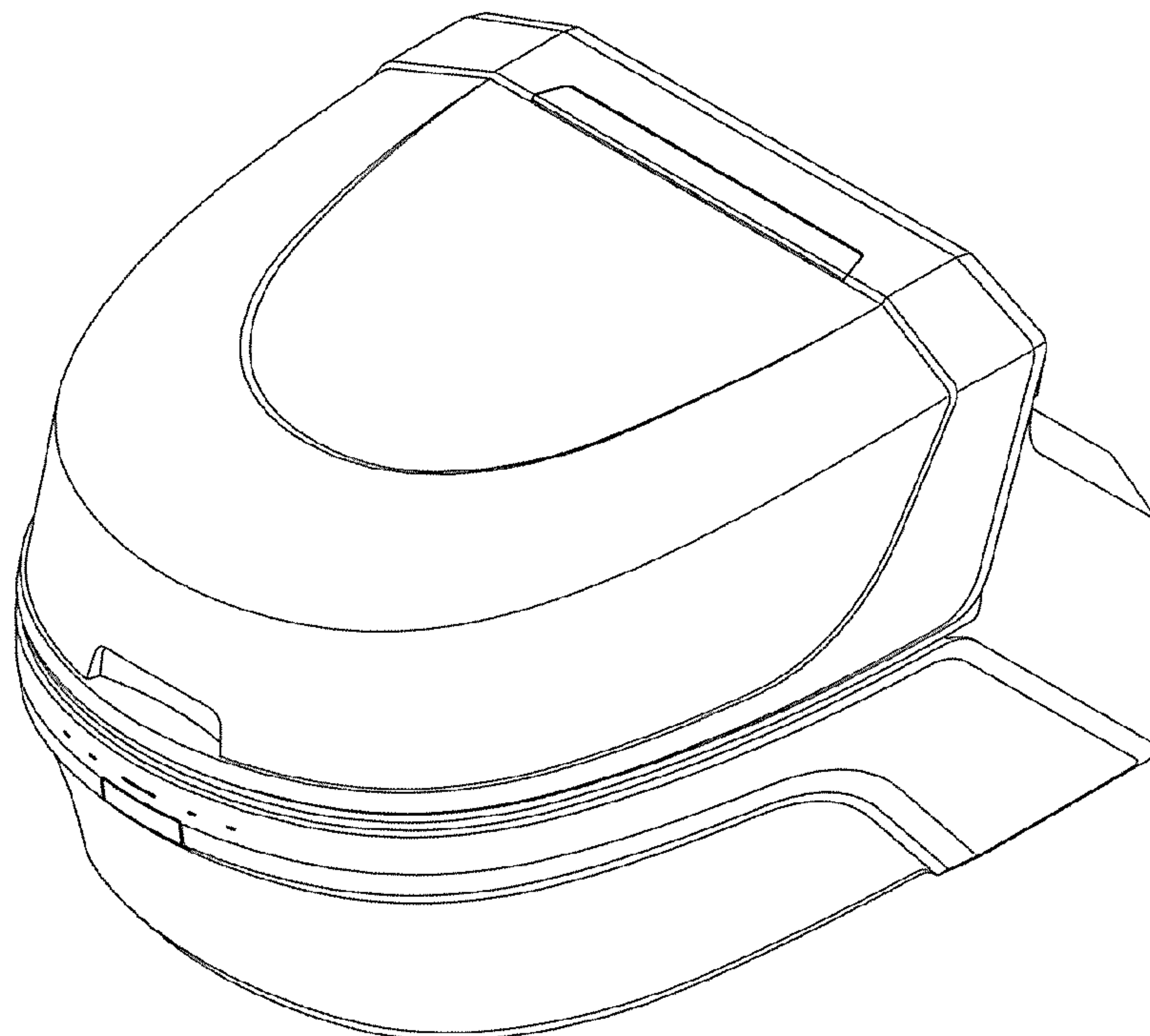
FIG. 6 is a right side view thereof;

FIG. 7 is a top view thereof; and,

FIG. 8 is a bottom view thereof.

See application file for complete search history.

1 Claim, 8 Drawing Sheets



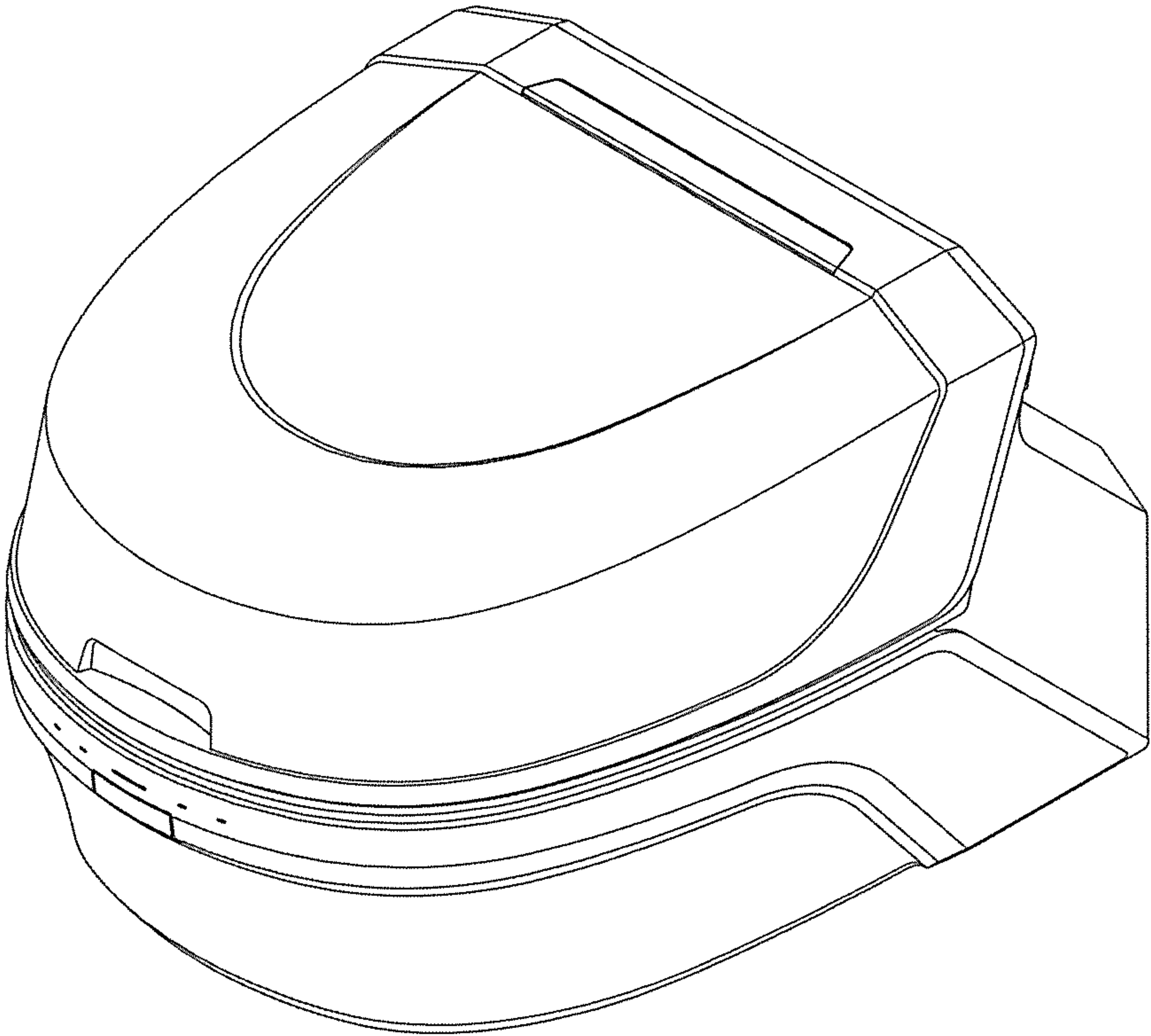


FIG.1

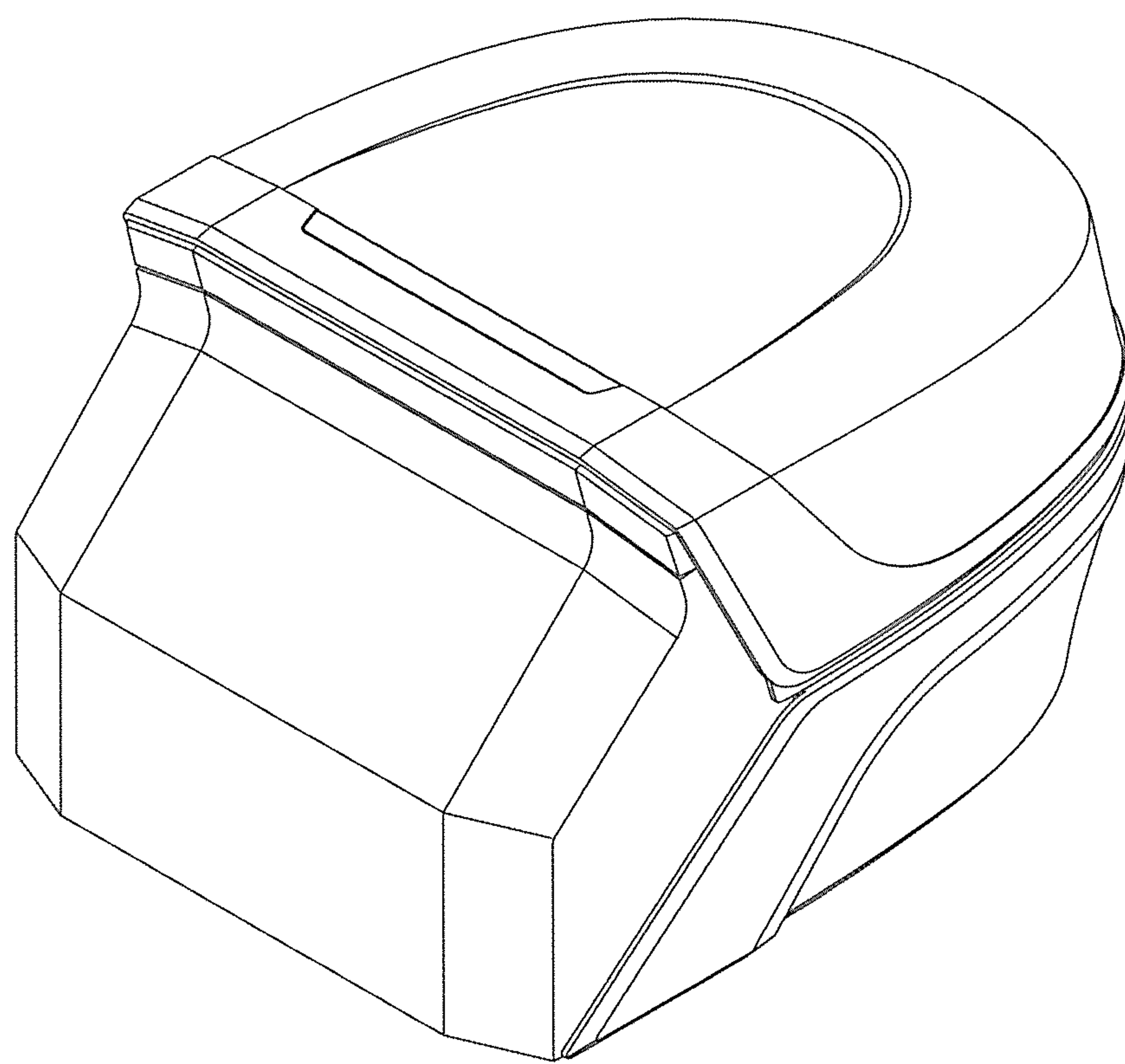


FIG.2

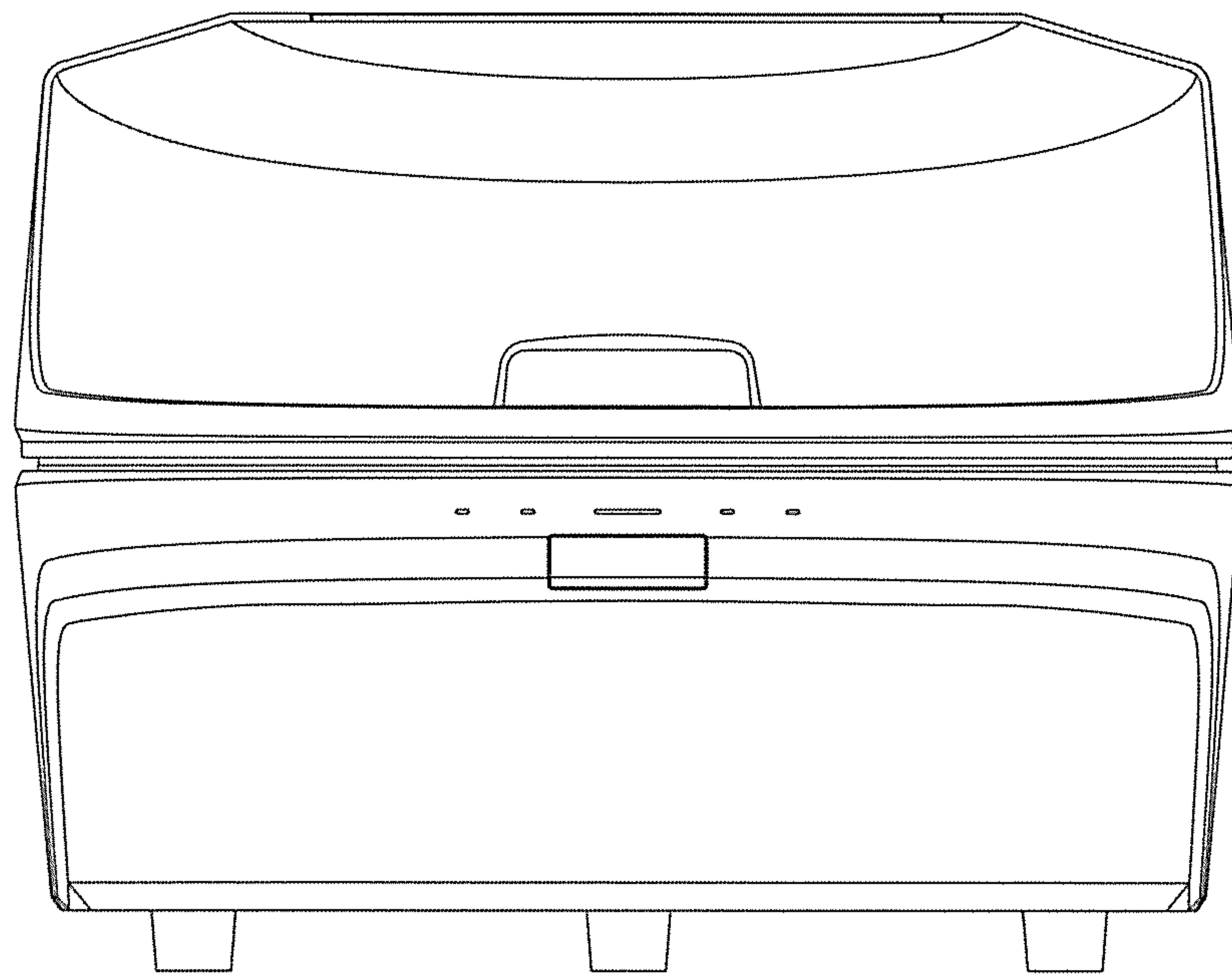


FIG.3

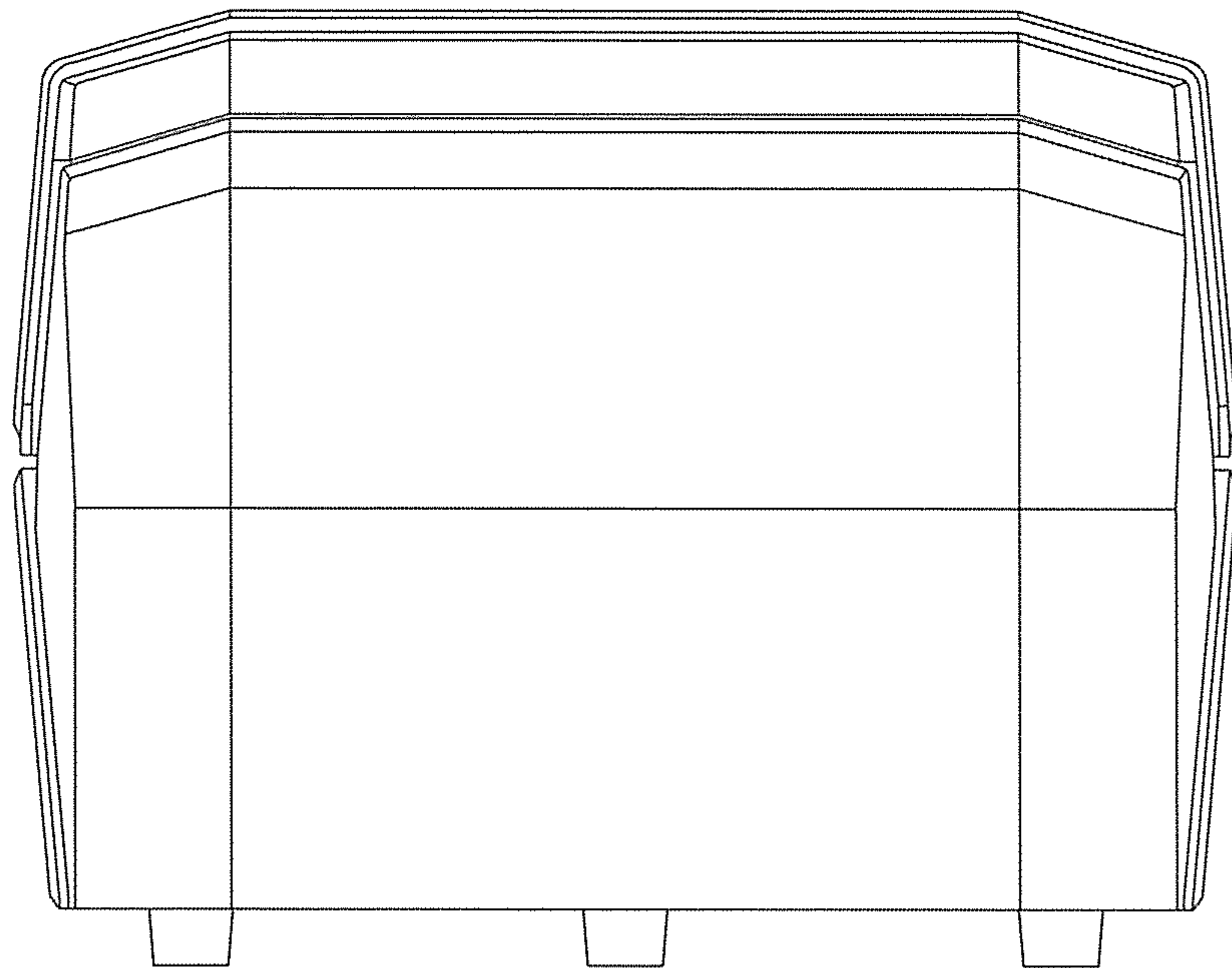


FIG.4

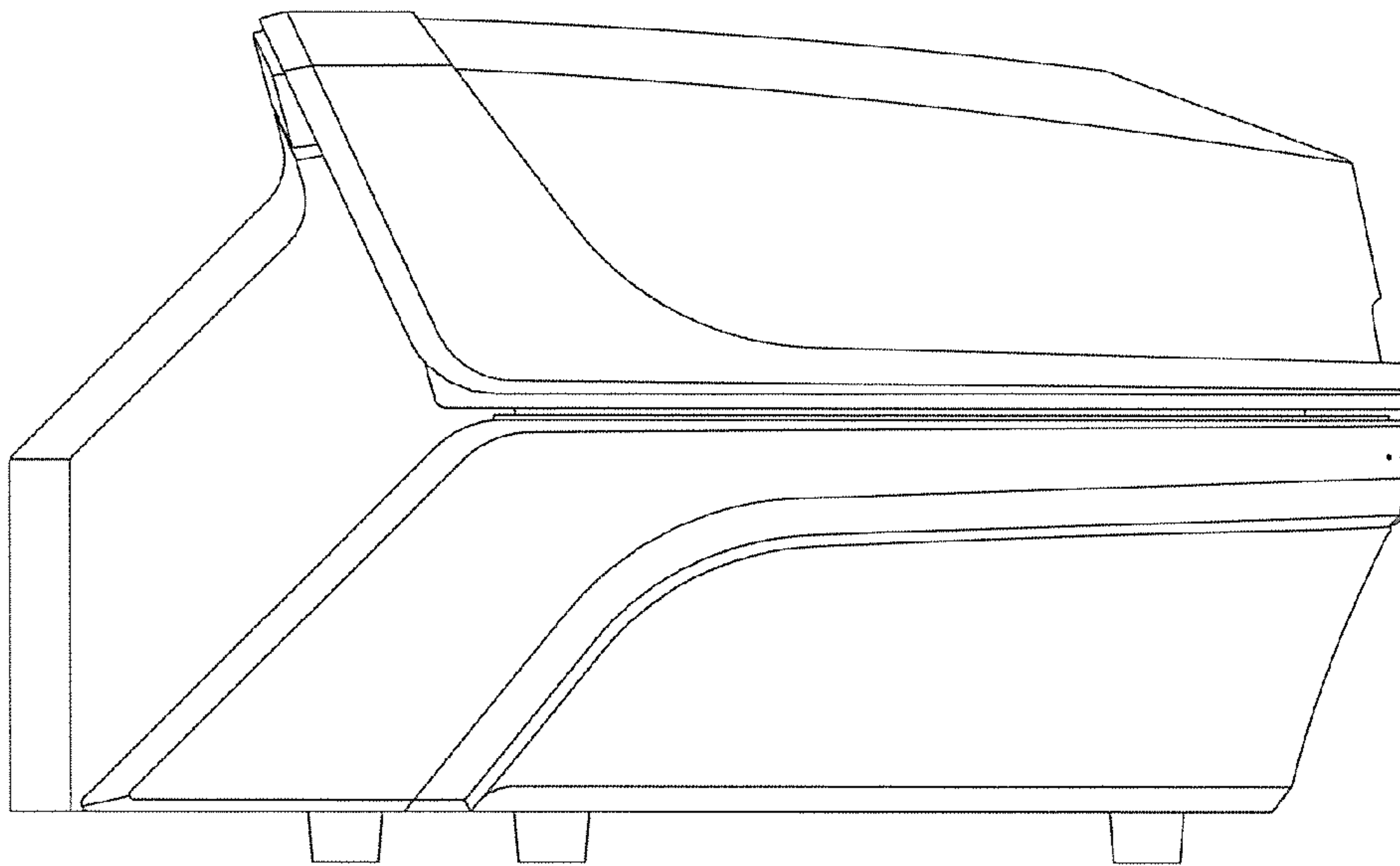


FIG.5

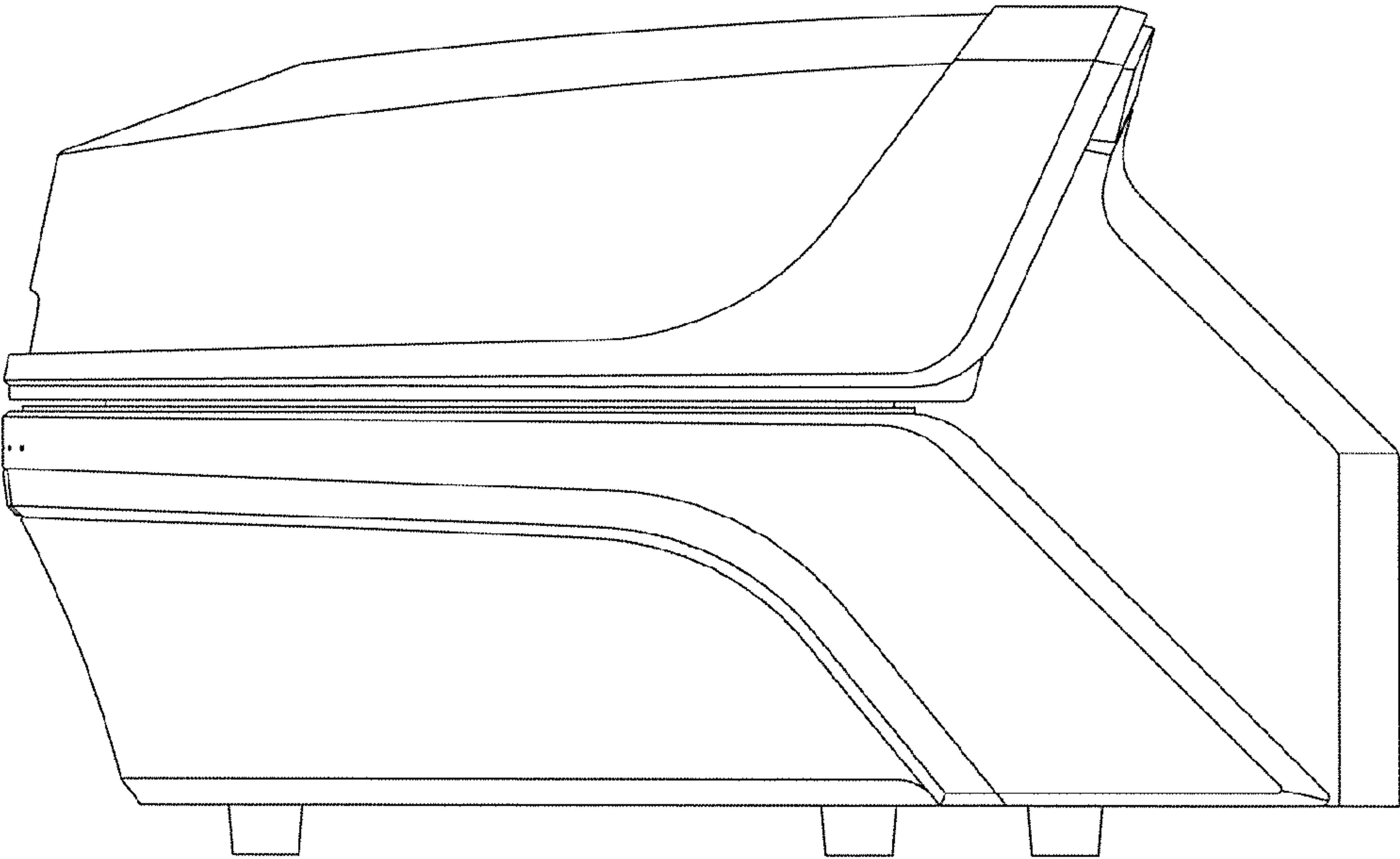


FIG.6

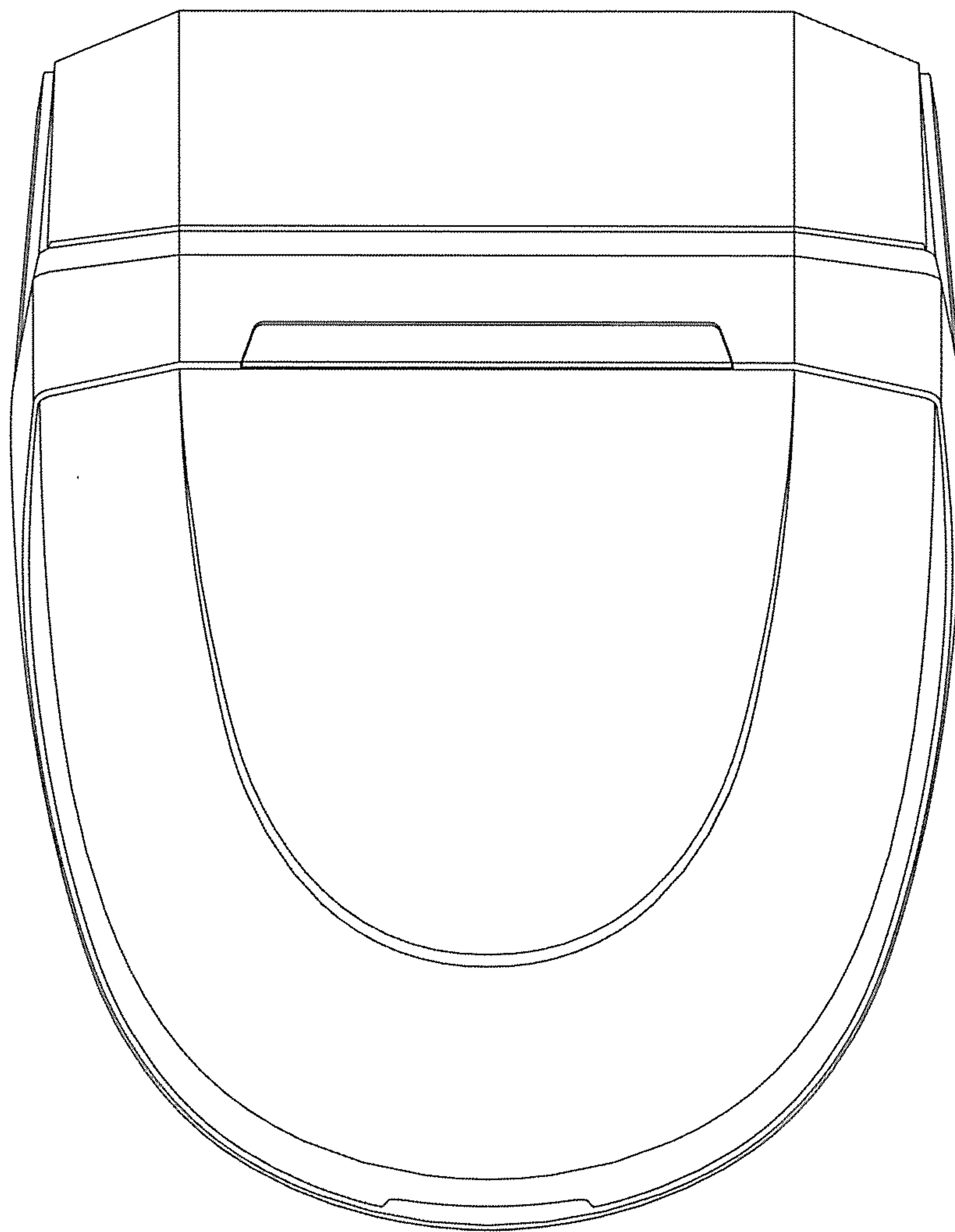


FIG.7

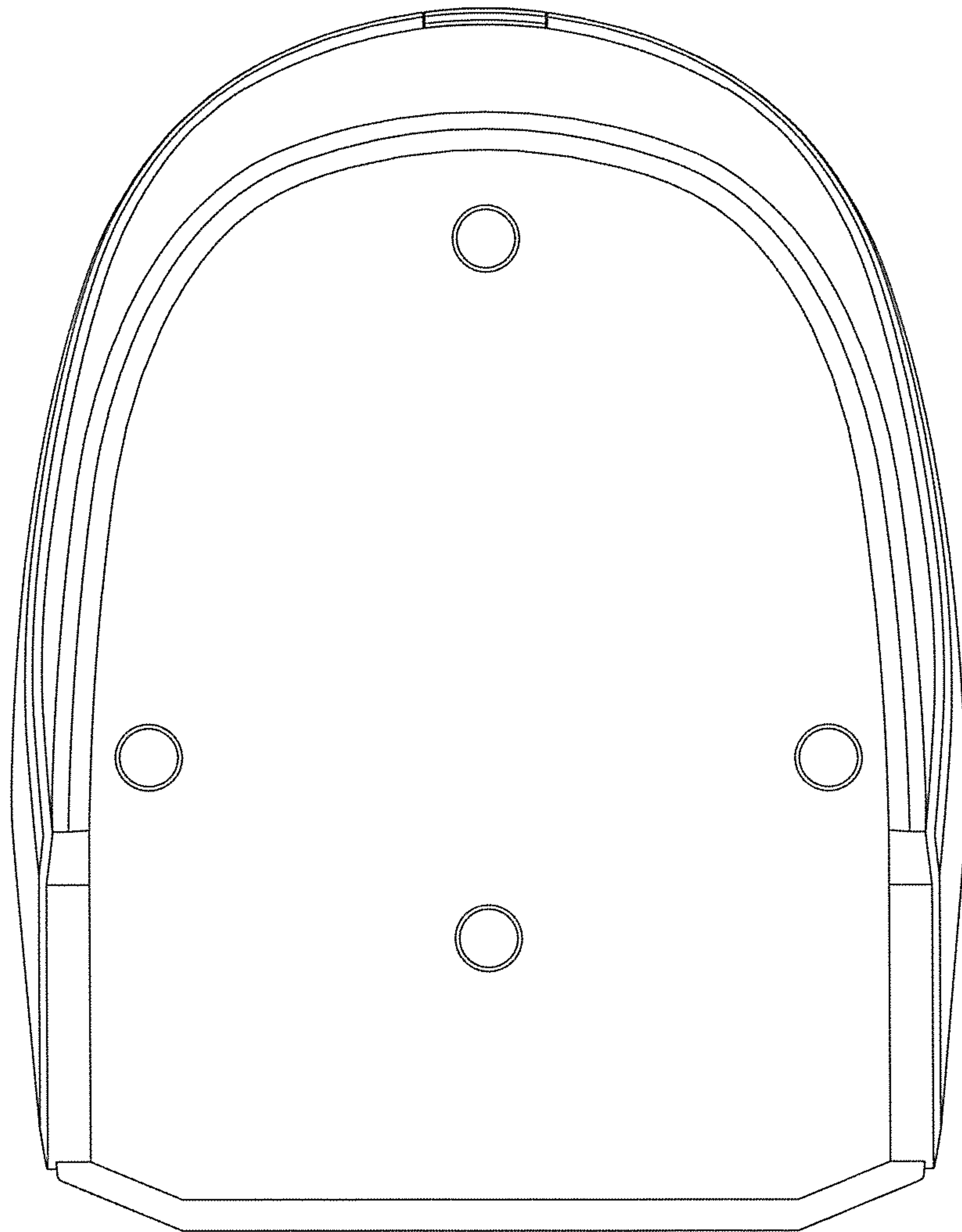


FIG.8